

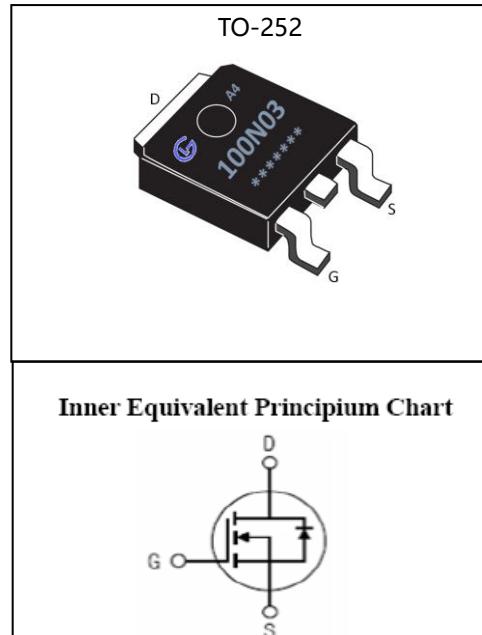
***GL Silicon N-Channel Power MOSFET***
**General Description :**

The GL100N03A4 uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications. The package form is TO-252, which accords with the RoHS standard.

$V_{DSS}$	30	V
$I_D$	100	A
$P_D$	105	W
$R_{DS(ON)max}$	5.5	$m\Omega$

**Features :**

- $R_{DS(ON)} < 5.5m\Omega$  @  $V_{GS}=10V$  (Typ4.1mΩ)
- High density cell design for ultra low  $R_{ds(on)}$
- Fully characterized avalanche voltage and current
- Excellent package for good heat dissipation


**Applications :**

- Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply

**Absolute (  $T_c = 25^\circ C$  unless otherwise specified ) :**

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	30	V
$I_D$	Continuous Drain Current	100	A
	Continuous Drain Current ( $T_c=100^\circ C$ )	80	A
$I_{DM}$	Pulsed Drain Current	400	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$P_D$	Power Dissipation	105	W
$E_{AS}$	Single pulse avalanche energy <sup>a5</sup>	1200	mJ
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	175, -55 to 175	°C



# GL100N03A4

无锡光磊电子科技有限公司

## GL Silicon N-Channel Power MOSFET

**Electrical Characteristics** (  $T_c = 25^\circ\text{C}$  unless otherwise specified ) :

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu\text{A}$	30	--	--	V
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=30V, V_{GS} = 0V, T_a = 25^\circ\text{C}$	--	--	1.0	$\mu\text{A}$
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+20V$	--	--	0.1	$\mu\text{A}$
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-20V$	--	--	-0.1	$\mu\text{A}$

ON Characteristics <sup>a3</sup>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=50A$	--	4.1	5.5	$\text{m}\Omega$
$V_{GS(\text{TH})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0	1.7	3.0	V

Pulse width  $t_p \leq 380\mu\text{s}, \delta \leq 2\%$

Dynamic Characteristics <sup>a4</sup>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$g_{fs}$	Forward Transconductance	$V_{DS}=5V, I_D=20A$	32	--	--	S
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=15V$	--	4500	--	pF
$C_{oss}$	Output Capacitance	$f=1.0\text{MHz}$	--	1050	--	
$C_{rss}$	Reverse Transfer Capacitance		--	540	--	

Resistive Switching Characteristics <sup>a4</sup>						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(\text{ON})}$	Turn-on Delay Time	$V_{DD}=10V, I_D=30A$	--	26	--	ns
$t_r$	Rise Time		--	25	--	
$t_{d(\text{OFF})}$	Turn-Off Delay Time		--	90	--	
$t_f$	Fall Time		--	35	--	
$Q_g$	Total Gate Charge	$V_{DD}=10V, I_D=30A$	--	38	--	nC
$Q_{gs}$	Gate to Source Charge		--	8.5	--	
$Q_{gd}$	Gate to Drain ( "Miller" )Charge		--	13	--	

**GL Silicon N-Channel Power MOSFET**
**Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current <sup>a2</sup> (Body Diode)		--	--	180	A
$V_{SD}$	Diode Forward Voltage <sup>a3</sup>	$I_S=100A, V_{GS}=0V$	--	--	1.5	V

Symbol	Parameter	Typ.	Units
$R_{eJC}$	Junction-to-Case <sup>a2</sup>	1.43	°C/W

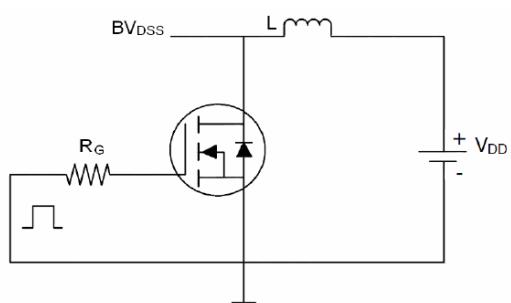
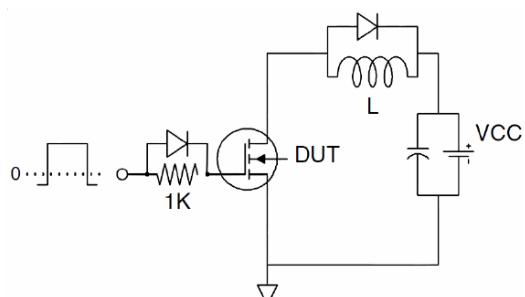
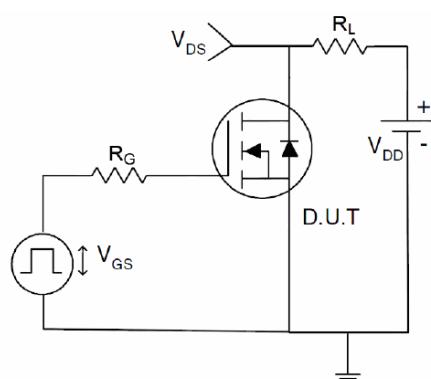
<sup>a1</sup> : Repetitive Rating: Pulse width limited by maximum junction temperature.

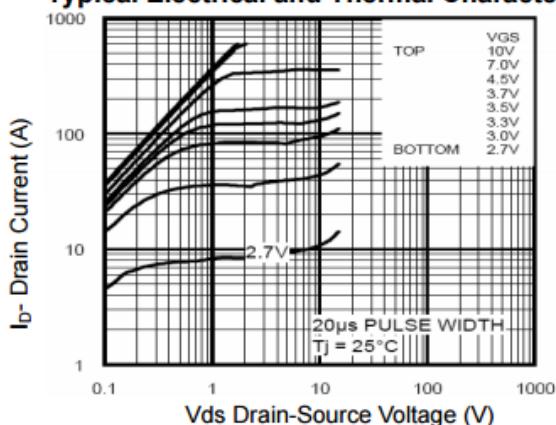
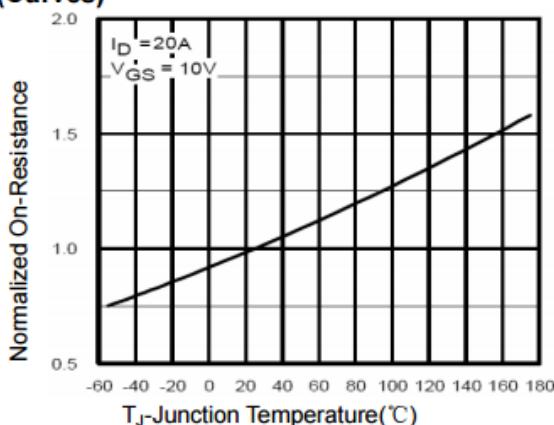
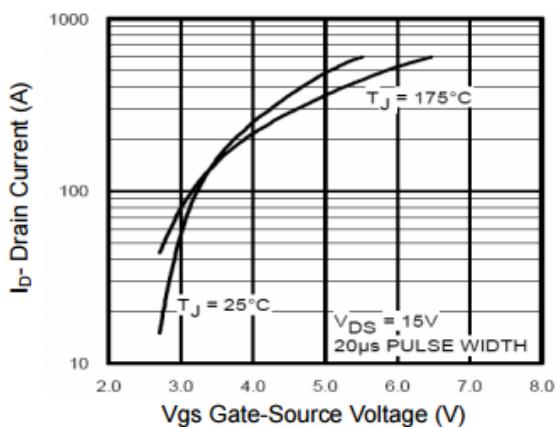
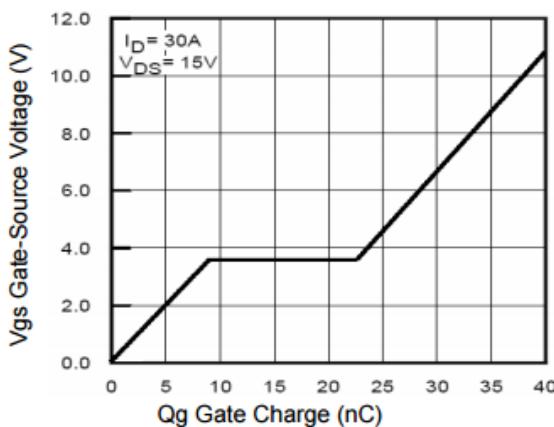
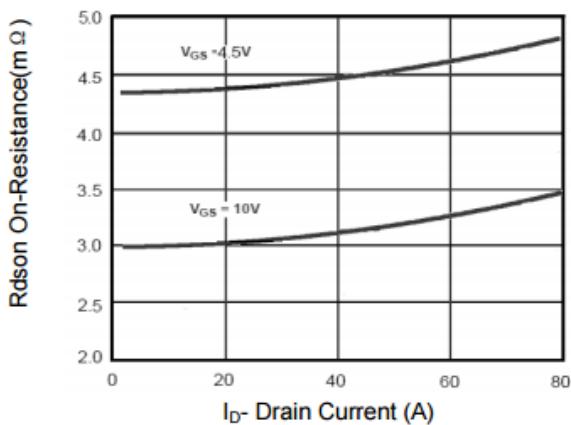
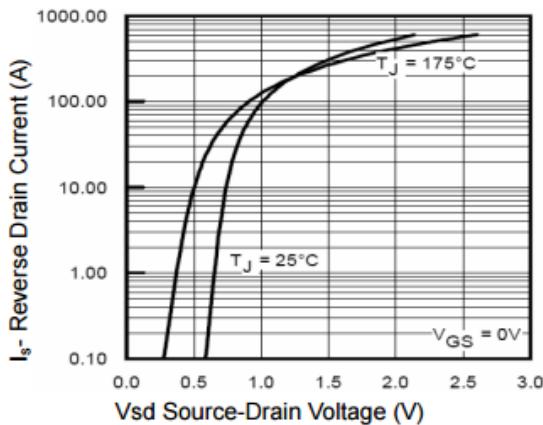
<sup>a2</sup> : Surface Mounted on FR4 Board,  $t \leq 10\text{sec}$ .

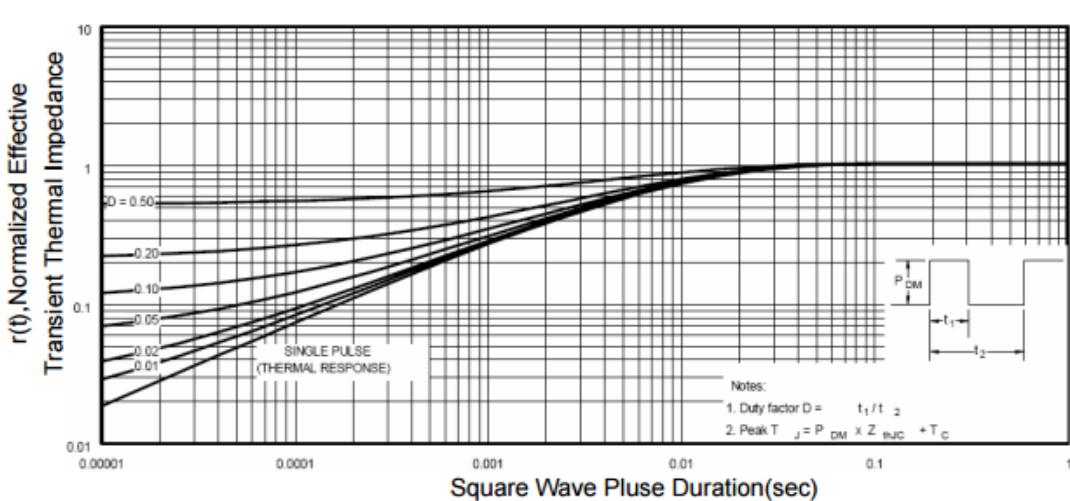
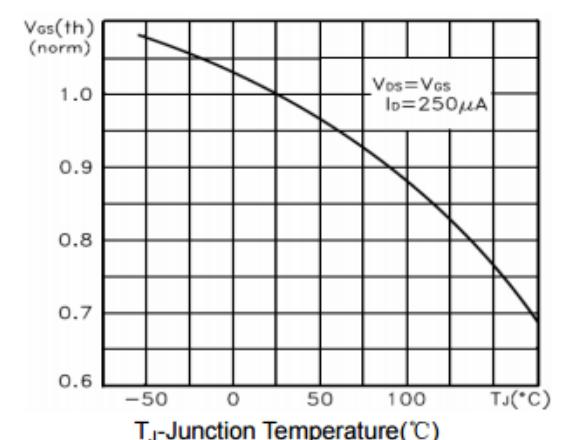
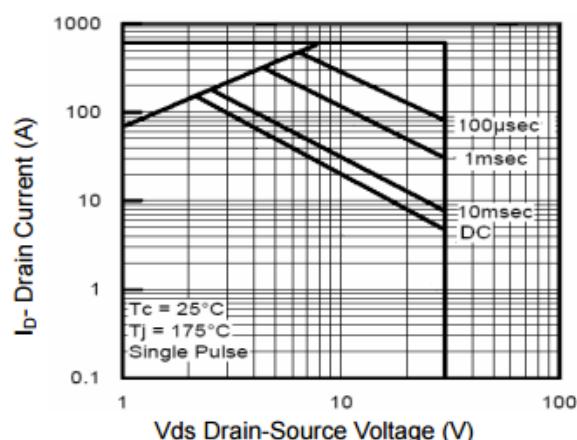
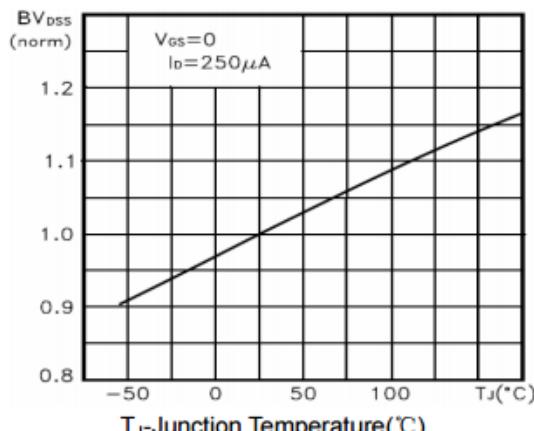
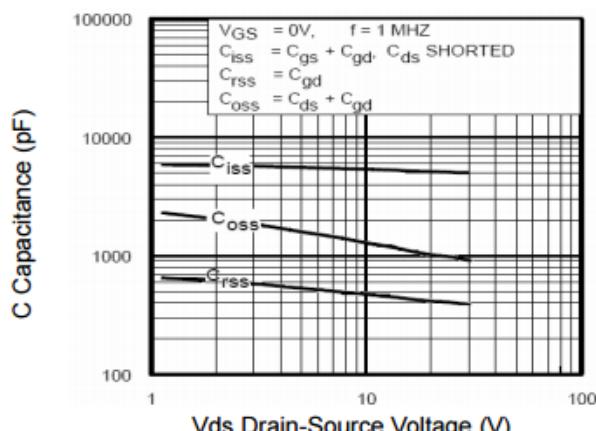
<sup>a3</sup> : Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ .

<sup>a4</sup> : Guaranteed by design, not subject to production

<sup>a5</sup> : EAS condition :  $T_j=25^\circ\text{C}, V_{DD}=15\text{V}, V_G=10\text{V}, L=0.5\text{mH}, R_g=25\Omega$

**Test circuit**
**1) EAS test Circuit**

**2) Gate charge test Circuit**

**3) Switch Time Test Circuit**


**GL Silicon N-Channel Power MOSFET**
**Typical Electrical and Thermal Characteristics (Curves)**

**Figure 1 Output Characteristics**

**Figure 4 Rdson-JunctionTemperature**

**Figure 2 Transfer Characteristics**

**Figure 5 Gate Charge**

**Figure 3 Rdson- Drain Current**

**Figure 6 Source- Drain Diode Forward**

**GL Silicon N-Channel Power MOSFET**


TEL:0755-23068119